

Application/Control No.	Applicant(s)/Patent under Reexamination
10/754,389	HAN ET AL.
Examiner	Art Unit
Nathan W. Ha	2814

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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